

• General Description

It combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$.

• Features

- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

• Application

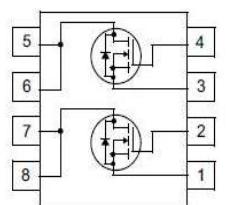
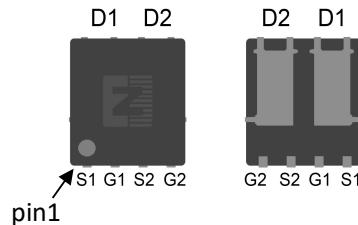
- BLDC Motor driver
- DC-DC
- Battery protection

• Ordering Information:

Part NO.	ZMD68404N
Marking	ZMD68404
Packing Information	REEL TAPE
Basic ordering unit (pcs)	3000

• Absolute Maximum Ratings ($T_c=25^\circ\text{C}$)

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	V_{DS}		40	V
Gate-Source Voltage	V_{GS}		± 20	V
Continuous Drain Current	I_D	$T_c=25^\circ\text{C}$	47	A
	I_D	$T_c=75^\circ\text{C}$	38	A
	I_D	$T_c=100^\circ\text{C}$	31	A
Pulsed Drain Current	I_{DM}	Pulsed; $t_p \leq 10 \mu\text{s}$; $T_{mb} = 25^\circ\text{C}$	188	A
Total Power Dissipation	P_D	$T_c=25^\circ\text{C}$	35	W
Total Power Dissipation	P_D	$T_A=25^\circ\text{C}$	2.5	W
Operating Junction Temperature	T_J		-55 to +150	$^\circ\text{C}$
Storage Temperature	T_{STG}		-55 to +150	$^\circ\text{C}$
Single Pulse Avalanche Energy	E_{AS}	$L=0.1\text{mH}$, $V_{GS}=10\text{V}$, $R_g=25\Omega$,	100	mJ
		$L=0.5\text{mH}$, $V_{GS}=10\text{V}$, $R_g=25\Omega$,	190	mJ
ESD Level (HBM)			CLASS 2	


 $V_{DS} = 40\text{V}$
 $R_{DS(ON)} = 6\text{m}\Omega$
 $I_D = 47\text{A}$


DFN5*6





•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R _{thJC}		-	3.6	°C/W
Thermal resistance, junction-ambient ^①	R _{thJA}		-	50	°C/W
Soldering temperature	T _{sold}		-	260	°C

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250uA	40			V
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} =V _{DS} , I _D =250uA	1.3	1.8	2.5	V
Drain-Source Leakage Current	I _{DSS}	V _{GS} =0V, V _{DS} = 40V			1.0	uA
Gate- Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} = 0V			100	nA
Static Drain-source On Resistance	R _{DS(ON)}	V _{GS} =10V, I _D = 18A		6	9	mΩ
		V _{GS} =4.5V, I _D = 16A		8	12	mΩ
Forward Transconductance	g _{FS}	V _{DS} =5V, I _{SD} = 10A		8		s
Diode Forward Voltage	V _{FSD}	V _{GS} =0V, I _{SD} = 18A			1.3	V

•Dynamic characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	C _{iss}	f = 1MHz, V _{DS} =25V	-	3300	-	pF
Output capacitance	C _{oss}		-	232	-	
Reverse transfer capacitance	C _{rss}		-	171	-	
Gate Resistance	R _g	f = 1MHz	-	1.4		Ω
Total gate charge	Q _g	V _{DD} = 15V, I _D = 20A, V _{GS} = 10V	-	51	-	nC
	Q _g (4.5v)		-	24	-	
Gate - Source charge	Q _{gs}		-	9	-	
Gate - Drain charge	Q _{gd}		-	9.6	-	
Turn-ON Delay time	t _{D(on)}	V _{GS} =10V,V _{DS} =15V, R _G =3.3Ω, I _D =20A	-	10	-	ns
Turn-ON Rise time	t _r		-	55	-	ns
Turn-Off Delay time	t _{D(off)}		-	25	-	ns
Turn-Off Fall time	t _f		-	42	-	ns
Reverse Recovery Time	t _{RR}	V _{DD} =20V, dI _S /dt = 100A/us, I _S =20A	-	23	-	ns
Reverse Recovery Charge	Q _{RR}		-	19	-	nC



Fig.1 Gate-Charge Characteristics

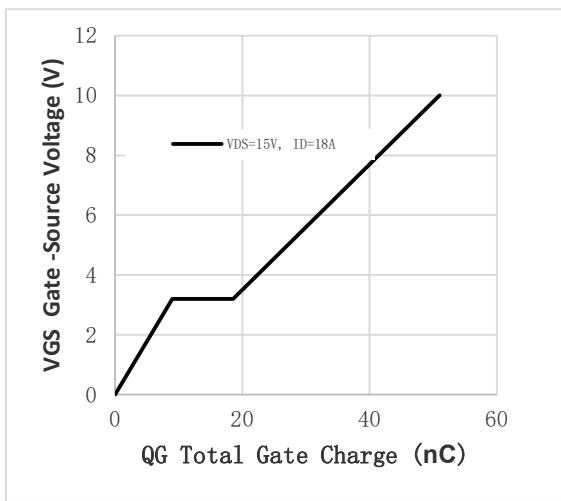


Fig.2 Capacitance Characteristics

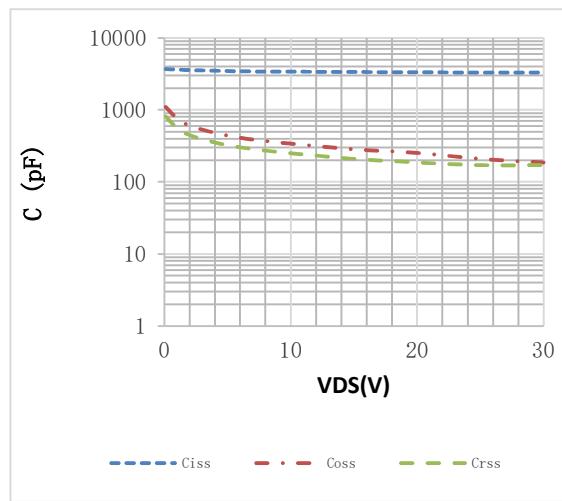


Fig.3 Power Dissipation

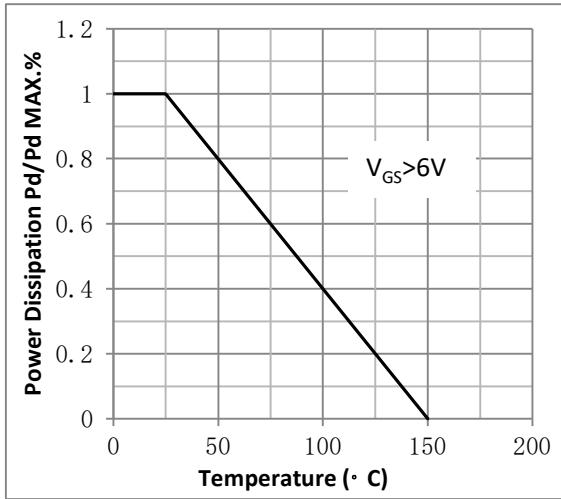


Fig.4 Typical output Characteristics

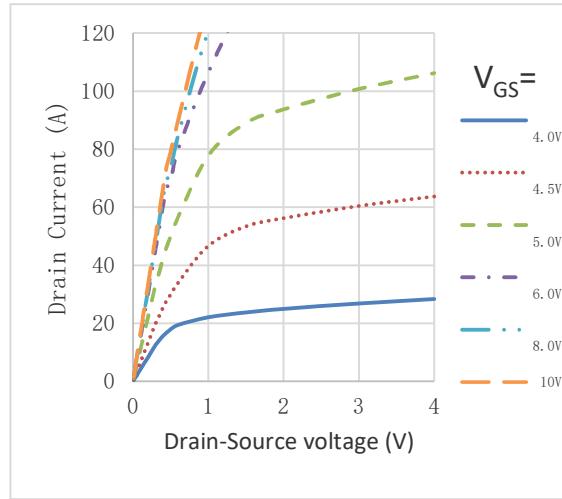


Fig.5 Threshold Voltage V.S Junction Temperature

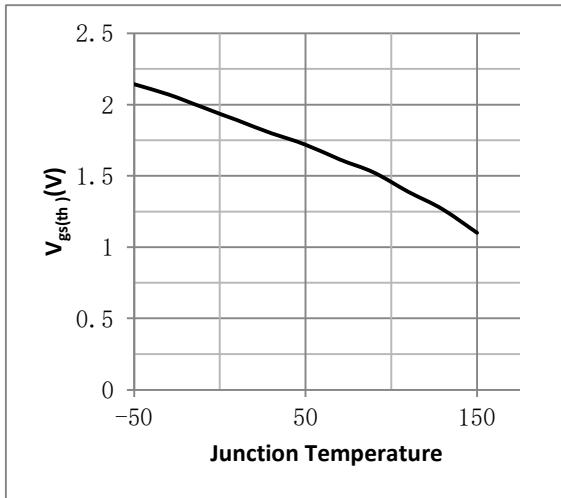


Fig.6 Resistance V.S Drain Current

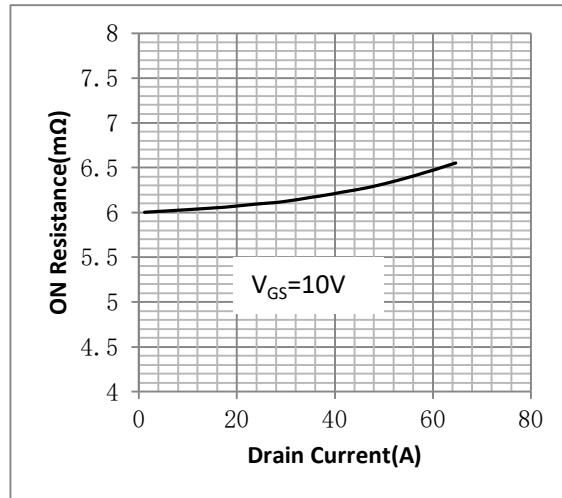


Fig.7 On-Resistance VS Gate Source Voltage

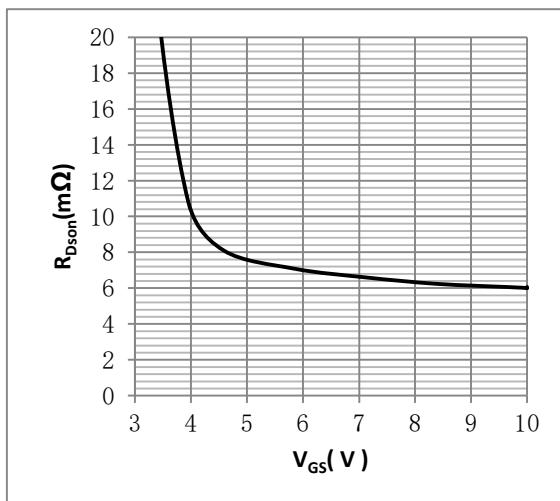


Fig.8 On-Resistance V.S Junction Temperature

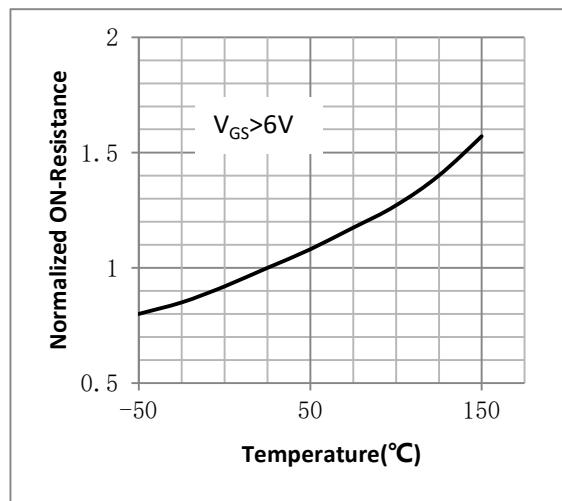


Figure 9. Diode Forward Voltage vs. Current

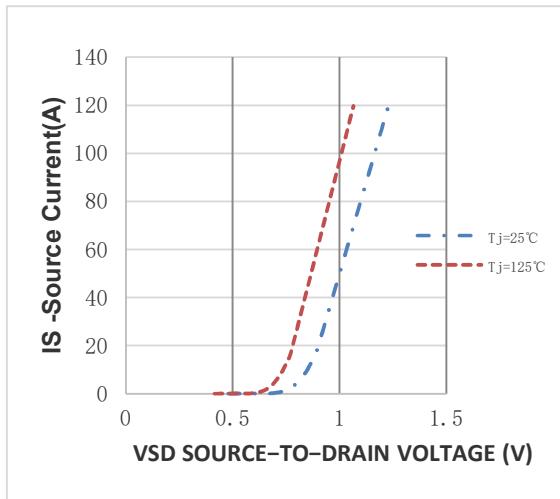


Figure 10. Transfer Characteristics

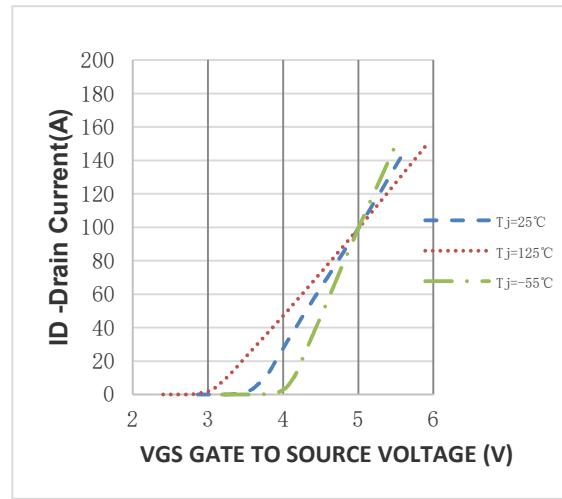
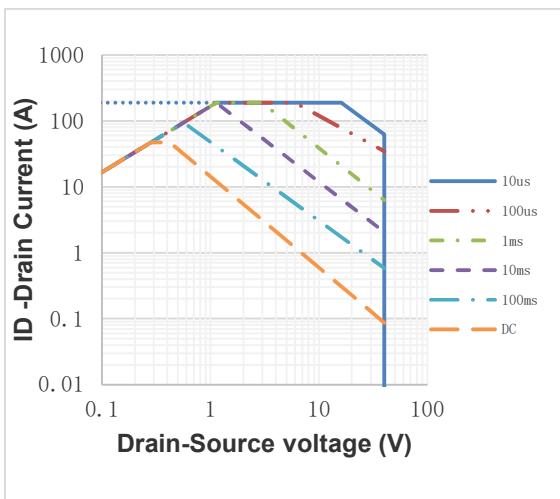
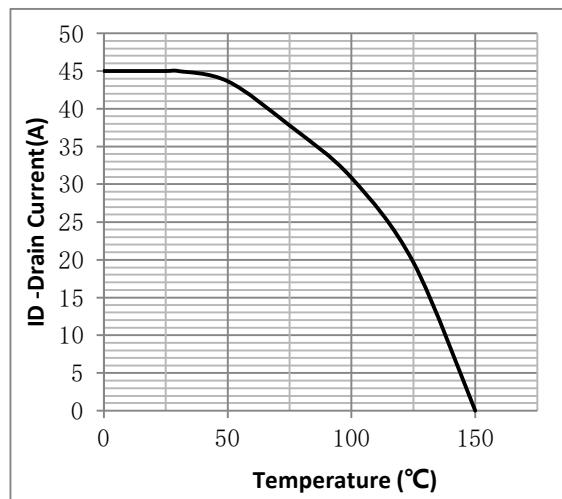
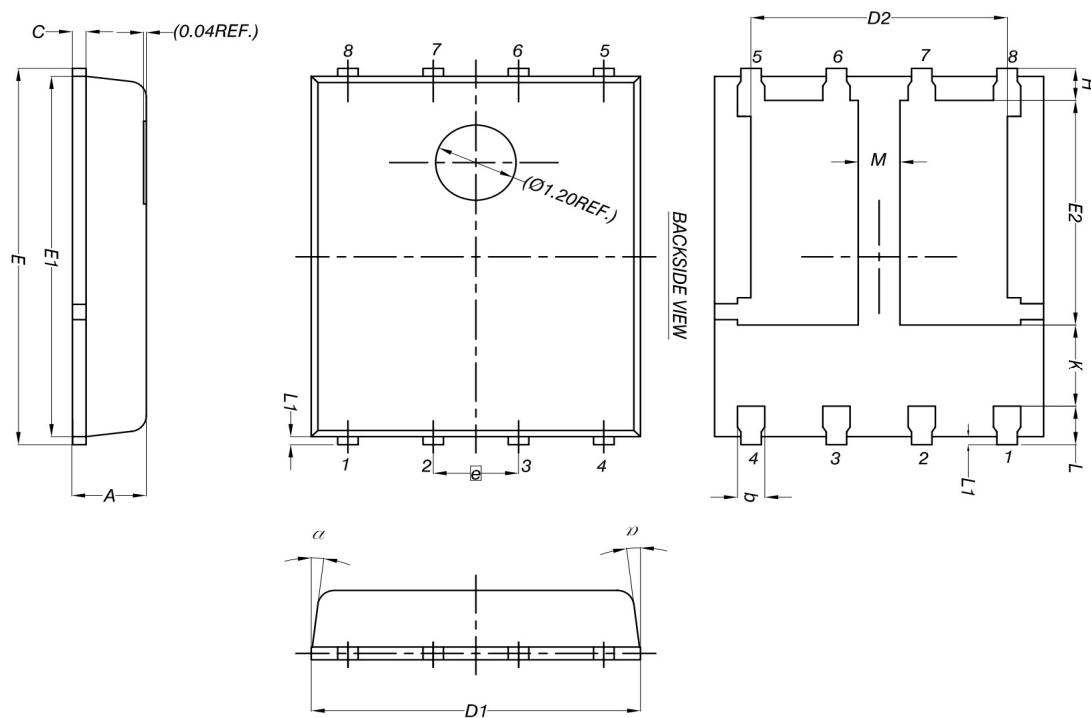


Fig.11 Safe Operating Area

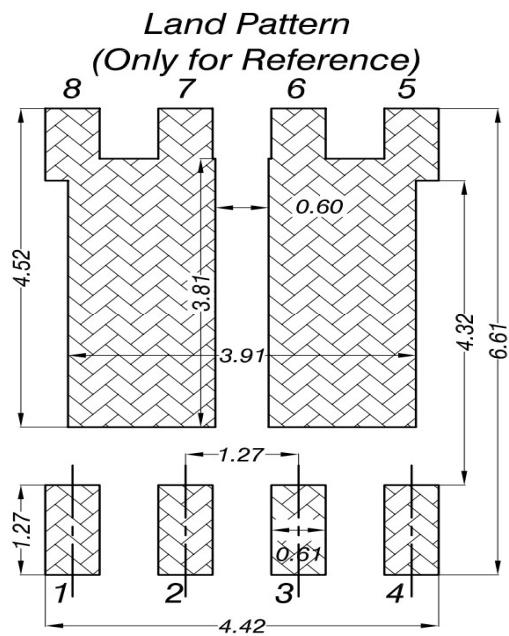
Fig.12 ID vs. Case Temperature^②



•DFN5*6 Package Outline



DIM.	MILLIMETERS		
	MIN.	NUM.	MAX.
A	0.90	1.00	1.15
b	0.33	0.41	0.51
c	0.19	0.25	0.29
D1	4.80	4.90	5.00
D2	3.60	3.95	4.30
E	5.90	6.00	6.10
E1	5.70	5.75	5.80
E2	3.28	3.58	3.88
e 1.27 BSC			
H	0.41	0.51	0.61
K	1.10	-	-
L	0.51	0.61	0.71
L1	0.06	0.13	0.2
M	0.50	-	-
a	0°	-	12°



**Note:**

① Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;

② Practically the current will be limited by PCB, thermal design and operating temperature.
VGS=10V.

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Revision History

Version	Date	Change
A	2021.2.3	
B	2021.9.5	1.Add Reach, HF figure
C	2023.12.20	corrected.2.Correct dynamic characteristics and characteristic curves.